Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/734,134	JANG, JAE-BUM	
Examiner	Art Unit	
TAN X. DINH	2627	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
EAST (see search history printout)	12/19/2007	T.D